

	Type	Hits	Search Text	DBs	Time Stamp	Comments
1	BRS	772	( id or ident\$4 or identification\$1 ) near7 repair\$3	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 11:43	
2	BRS	62	(repair\$3 with spare\$1) and (( id or ident\$4 or identification\$1 ) near7 repair\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 07:57	
3	BRS	2	( i adj d ) near7 repair\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 08:05	
4	BRS	135	(( id or ident\$4 or identification\$1 ) near7 repair\$3) with ( memory or memories or wafer or dice or ic )	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 10:27	
5	BRS	66	(repair\$3 with spare\$1) and (( id or ident\$4 or identification\$1 ) near7 repair\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 07:57	
6	BRS	2	( i adj d ) near7 repair\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 08:45	
7	BRS	8	( id or ident\$4 or identification\$1 ) near3 ( fuse7 or fuses ) near5 laser	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 10:06	
8	BRS	6	(( id or ident\$4 or identification\$1 ) near3 ( undergo\$3 ) ) with repair\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 10:09	
9	BRS	18	(( id or ident\$4 or identification\$1 ) near7 ( undergo\$3 ) ) with repair\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 10:09	

Error Definiti on	Errors
1	0
2	0
3	0
4	0
5	0
6	0
7	0
8	0
9	0

	Type	Hits	Search Text	DBs	Time Stamp	Comments
10	BRS	12	(( id or ident\$4 or identification\$1 ) near7 ( undergo\$3 ) ) with repair\$3) not ((( id or ident\$4 or identification\$1 ) near3 ( undergo\$3 ) ) with repair\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 10:10	
11	BRS	144	(( id or ident\$4 or identification\$1 ) near7 repair\$3) with ( memory or memories or wafer or dice or ic )	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/18 10:27	
12	BRS	358	(( id or identification ) with ( chip or die or wafer or ic or ( integrated adj circuit ))) with (( repair\$4 or good or bad or defect\$3 or nonfunctional or fail\$3 or scrap\$4 or waste or unrepairable ) with ( chip or die or wafer or ic or ( integrated adj circuit )))	USPAT	2003/12/18 11:48	
13	BRS	159	(( id or identification ) with ( chip or die or wafer or ic or ( integrated adj circuit ))) with (( repair\$4 or good or bad or defect\$3 or nonfunctional or fail\$3 or scrap\$4 or waste or unrepairable ) with ( chip or die or wafer or ic or ( integrated adj circuit )))	US-PGPUB	2003/12/18 11:49	

	Error Definition	Errors
10		0
11		0
12		0
13		0

	Type	Hits	Search Text	DBs	Time Stamp	Comments
14	BRS	171	(( id or identification ) with ( chip or die or wafer or ic or ( integrated adj circuit ))) with (( repair\$4 or good or bad or defect\$3 or nonfunctional or fail\$3 or scrap\$4 or waste or unrepairable ) with ( chip or die or wafer or ic or ( integrated adj circuit )))	EPO; JPO; DERWENT; IBM_TDB	2003/12/31 12:41	

	Error Definition	Errors
14		0